

<b>Notice of References Cited</b>	Application/Control No. 10/708,175	Applicant(s)/Patent Under Reexamination YEH, WEN-YUAN	
	Examiner Jack Chen	Art Unit 2813	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2004/0000695 A1	01-2004	Matsuo, Kouji	257/412
	B	US-6,455,330 B1	09-2002	Yao et al.	438/3
	C	US-6,281,556 B1	08-2001	Gerritsen et al.	257/382
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
	O					
	P					
	Q					
	R					
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NON-PATENT DOCUMENTS

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